- Bidirectional Bus Transceivers in High-Density 20-Pin Packages
- True Logic
- 3-State Outputs
- Package Options Include Plastic Small-Outline (DW) Packages, Ceramic Chip Carriers (FK), and Standard Plastic (N) and Ceramic (J) 300-mil DIPs

description

These octal bus transceivers are designed for asynchronous two-way communication between data buses. These devices transmit data from the A bus to the B bus or from the B bus to the A bus, depending on the level at the direction-control (DIR) input. The output-enable (\overline{OE}) input can be used to disable the device so that the buses are effectively isolated.

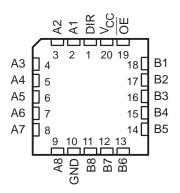
The -1 version of the SN74ALS645A is identical to the standard version, except that the recommended maximum I_{OL} is increased to 48 mA. There is no -1 version of the SN54ALS645A.

The SN54ALS645A and SN54AS645 are characterized for operation over the full military temperature range of -55° C to 125° C. The SN74ALS645A and SN74AS645 are characterized for operation from 0°C to 70°C.

SN54ALS645A, SN54AS645 J PACKAGE
SN74ALS645A, SN74AS645 DW OR N PACKAGE
(TOP VIEW)

DIR	1	υ	20	Vcc
A1	2		19] OE
A2			18] B1
A3			17] B2
A4			16] B3
A5			15] B4
A6	7		14] B5
A7			13] B6
A8	9		12] B7
GND	10		11] B8
				,

SN54ALS645A, SN54AS645...FK PACKAGE (TOP VIEW)



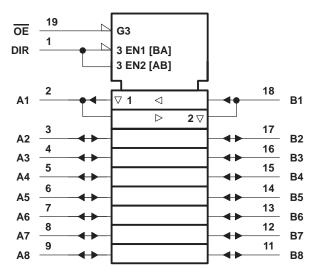
FUNCTION TABLE

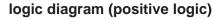
INP	UTS	
OE	DIR	OPERATION
L	L	B data to A bus
L	Н	A data to B bus
н	Х	Isolation

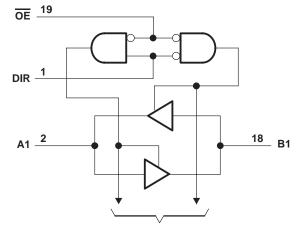
PRODUCTION DATA information is current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.

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logic symbol[†]







To Seven Other Transceivers

[†] This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)[‡]

Supply voltage, V _{CC}	
Input voltage, V _I : All inputs	
I/O ports	5.5 V
Operating free-air temperature range, T _A : SN54ALS645A	-55°C to 125°C
SN74ALS645A	0°C to 70°C
Storage temperature range	-65°C to 150°C

Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

recommended operating conditions

		SN54ALS645A			SN7	UNIT		
		MIN	NOM	MAX	MIN	NOM	MAX	UNIT
V _{CC}	Supply voltage	4.5	5	5.5	4.5	5	5.5	V
VIH	High-level input voltage	2			2			V
VIL	Low-level input voltage			0.7			0.8	V
ЮН	High-level output current			-12			-15	mA
				12			24	mA
IOL	Low-level output current						48§	MA
TA	Operating free-air temperature	-55		125	0		70	°C

Applies only to the -1 version and only if V_{CC} is between 4.75 V and 5.25 V



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PARAMETER		TEST CONDITIONS		SN	54ALS64	5A	SN7	5A	UNIT	
		TEST CO	CONDITIONS		TYP†	MAX	MIN	TYP [†]	MAX	UNIT
VIK		V _{CC} = 4.5 V,	lj = – 18 mA			-1.5			-1.5	V
		$V_{CC} = 4.5 V \text{ to } 5.5 V,$	I _{OH} = -0.4 mA	V _{CC} -2	2		V _{CC} -2	2		
Val			I _{OH} = -3 mA	2.4	3.2		2.4	3.2		V
Vон		$V_{CC} = 4.5 V$	$I_{OH} = -12 \text{ mA}$	2						v
			I _{OH} = -15 mA				2			
			I _{OL} = 12 mA		0.25	0.4		0.25	0.4	
VOL		$V_{CC} = 4.5 V$	I _{OL} = 24 mA					0.35	0.5	V
			$I_{OL} = 48 \text{ mA}^{\ddagger}$					0.35	0.5	
1.	Control inputs		VI = 7 V			0.1			0.1	mA
łı	A or B ports	$V_{CC} = 5.5 V$	V _I = 5.5 V			0.1			0.1	mA
	Control inputs		VI = 2.7 V			20			20	۸
lΗ	A or B ports§	V _{CC} = 5.5 V,	V] = 2.7 V			20			20	μA
lu.	Control inputs					-0.1			-0.1	mA
۱Ľ	A or B ports§ $V_{CC} = 5.5 \text{ V},$		V _I = 0.4 V		-0.1				-0.1	mA
IO		V _{CC} = 5.5 V,	V _O = 2.25 V	-20		-112	-30		-112	mA
			Outputs high		30	48		30	45	
ICC		$V_{CC} = 5.5 V$	Outputs low		36	60		36	55	mA
			Outputs disabled		38	63		38	58	

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

[†] All typical values are at $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$.

[‡] Applies only to the -1 version and only if V_{CC} is between 4.75 V and 5.25 V § For I/O ports, the parameters I_{IH} and I_{IL} include the off-state output current.

The output conditions have been chosen to produce a current that closely approximates one half of the true short-circuit output current, IOS.

switching characteristics (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	CL R1 R2	= 50 pF = 500 Ω = 500 Ω	<u>),</u>	3	UNIT
			SN54ALS645A		SN74AL	S645A	
			MIN	MAX	MIN	MAX	
^t PLH	A or B	Dant	1	19	3	10	ns
^t PHL	AUB	B or A	1	14	3	10	115
^t PZH	OE	A an D	2	30	5	20	ns
^t PZL	ÛE	A or B	2	29	5	20	115
^t PHZ	OE	A or B	2	14	2	10	ns
^t PLZ	UE	AUR	2	30	4	15	115

[#] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.



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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)[†]

Supply voltage, V _{CC}	
Input voltage, VI: All inputs	
I/O ports	5.5 V
Operating free-air temperature range, T _A : SN54AS645	-55°C to 125°C
SN74AS645	0°C to 70°C
Storage temperature range	-65°C to 150°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

recommended operating conditions

		SN54AS645			SI	UNIT		
		MIN	NOM	MAX	MIN	NOM	MAX	UNIT
VCC	Supply voltage	4.5	5	5.5	4.5	5	5.5	V
VIH	High-level input voltage	2			2			V
VIL	Low-level input voltage			0.8			0.8	V
IOH	High-level output current			-12			-15	mA
IOL	Low-level output current			48			64	mA
TA	Operating free-air temperature	-55		125	0		70	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CO	NDITIONS	SI	SN54AS645		SN	174AS64	5	
		TEST CO	NDITIONS	MIN	TYP [‡]	MAX	MIN	TYP [‡]	MAX	UNIT
VIK		V _{CC} = 4.5 V,	lj = - 18 mA			-1.2			-1.2	V
		V _{CC} = 4.5 V to 5.5 V,	$I_{OH} = -2 \text{ mA}$	V _{CC} -2	2		V _{CC} -2	2		
Vari			I _{OH} = -3 mA	2.4	3.2		2.4	3.2		V
Vон		$V_{CC} = 4.5 V$	$I_{OH} = -12 \text{ mA}$	2.4						v
			I _{OH} = -15 mA				2.4			
Val			I _{OL} = 48 mA		0.3	0.55				V
VOL		$V_{CC} = 4.5 V$	I _{OL} = 64 mA					0.35	0.55	v
I .	Control inputs		V _I = 7 V			0.1			0.1	mA
1 ₁	A or B ports	V _{CC} = 5.5 V	V _I = 5.5 V			0.1			0.1	ША
I	Control inputs	V _{CC} = 5.5 V,	V ₁ = 2.7 V			20			20	μA
ΊН	A or B ports§	VCC = 5.5 V,	v = 2.7 v			70			70	μΑ
1	Control inputs		N 0 4 M			-0.5			-0.5	mA
۱Ľ	A or B ports§	$V_{CC} = 5.5 V,$	V ₁ = 0.4 V			-0.75			-0.75	ША
lo¶		V _{CC} = 5.5 V,	V _O = 2.25 V	-50		-150	-50		-150	mA
			Outputs high		62	97		62	97	
ICC		V _{CC} = 5.5 V	Outputs low		95	149		95	149	mA
			Outputs disabled		79	123		79	123	

[‡] All typical values are at V_{CC} = 5 V, T_A = 25° C.

§ For I/O ports, the parameters IIH and IIL include the off-state output current.

The output conditions have been chosen to produce a current that closely approximates one half of the true short-circuit output current, IOS.



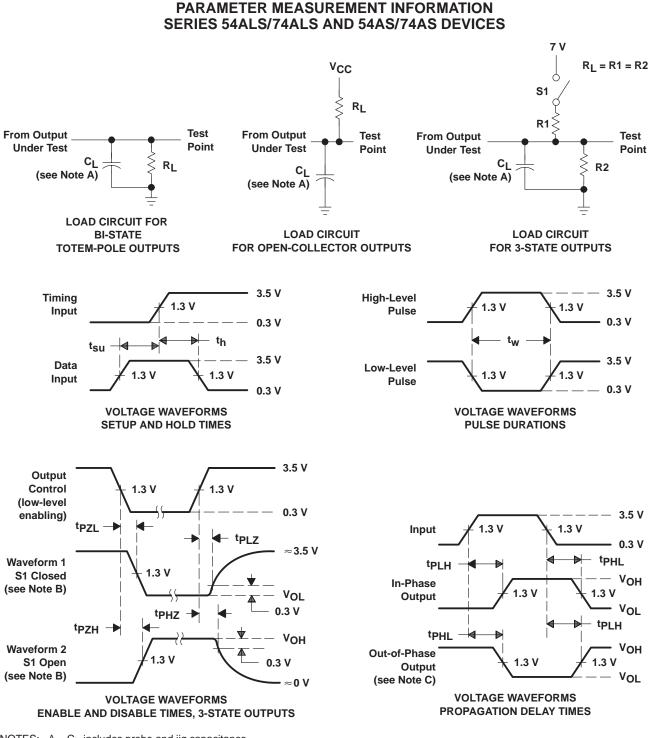
switching characteristics (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	CL R1 R2	= 50 pF = 500 Ω = 500 Ω	2,	V,	UNIT
			SN54A	S645	SN74A		
			MIN	MAX	MIN	MAX	
^t PLH	A or B	Dant	2	11	2	9.5	ns
^t PHL	AUD	B or A	2	10.5	2	9	115
^t PZH	OE	A D	2	12	2	11	ns
tPZL	ÛE	A or B	2	12	2	10	115
^t PHZ	OE	A or B	2	8	2	7	-
^t PLZ	UE	AUID	2	13	2	12	ns

[†] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.



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NOTES: A. C_L includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. When measuring propagation delay items of 3-state outputs, switch S1 is open.
- D. All input pulses have the following characteristics: PRR \leq 1 MHz, t_{f} = t_{f} = 2 ns, duty cycle = 50%.
- E. The outputs are measured one at a time with one transition per measurement.

Figure 1. Load Circuits and Voltage Waveforms



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